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SEMICONDUCTOR IM

FDG328P

P-Channel 2.5V Specified PowerTrench[®] MOSFET

General Description

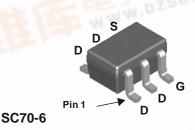
This P-Channel 2.5V specified MOSFET is produced in a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications for a wide range of gate drive voltages (2.5V - 12V).

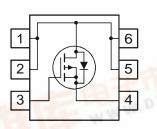
Applications

- Load switch
- Power management
- DC/DC converter

Features

- -1.5 A, -20 V. $R_{\text{DS(ON)}}$ = 0.145 Ω @ V_{GS} = -4.5 V $R_{DS(ON)} = 0.210 \ \Omega @ V_{GS} = -2.5 \ V$
- Low gate charge
- High performance trench technology for extremely low R_{DS(ON)}
- Compact industry standard SC70-6 surface mount package





Absolute Maximum Ratings T_{A=25°C unless otherwise noted}

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		± 12	V
ID	Drain Current – Continuous	(Note 1a)	-1.5	A
	- Pulsed		-6	1.1.1
PD	Power Dissipation for Single Operation	(Note 1a)	0.75	W
		(Note 1b)	0.48	-10.0 G
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C
Therma	I Characteristics	S92 1	BIT	
R _{0JA}	Thermal Resistance, Junction-to-Ambient	(Note 1b)	260	°C/W

Package Marking and Ordering Information

		g				
-	Device Marking	Device	Reel Size	Tape width	Quantity	
	.28	FDG328P	7"	8mm	3000 units	



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2000 Fairchild Semiconductor International

FDG328P Rev C(W)

FDG328P

October 2000

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	racteristics					
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	I_D = -250 µA, Referenced to 25°C		-9		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$			-1	μA
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	$V_{GS} = -12 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-0.6		-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$, Referenced to 25°C		3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -1.2 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}, T_I = 125^{\circ}\text{C}$		120 169 156	145 210 203	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}, T_J=125^{\circ}\text{C}$ $V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-3			Α
g FS	Forward Transconductance	$V_{DS} = -5 V$, $I_D = -1.5 A$		5		S
Dynami	c Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$		337	7	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		88		pF
C _{rss}	Reverse Transfer Capacitance	1		51		pF
Switchir	ng Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 V, I_D = 1 A,$		9	18	ns
t _r	Turn–On Rise Time	$V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		12	22	ns
t _{d(off)}	Turn-Off Delay Time			10	20	ns
t _f	Turn-Off Fall Time			5	10	ns
Qg	Total Gate Charge	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1.5 \text{ A},$		3.7	6	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -4.5 V$		0.7	'	nC
Q _{gd}	Gate–Drain Charge		1.3		;	nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain–Sourc				-0.62	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = -0.62 A$ (Note 2)		-0.7	-1.2	V

Notes:

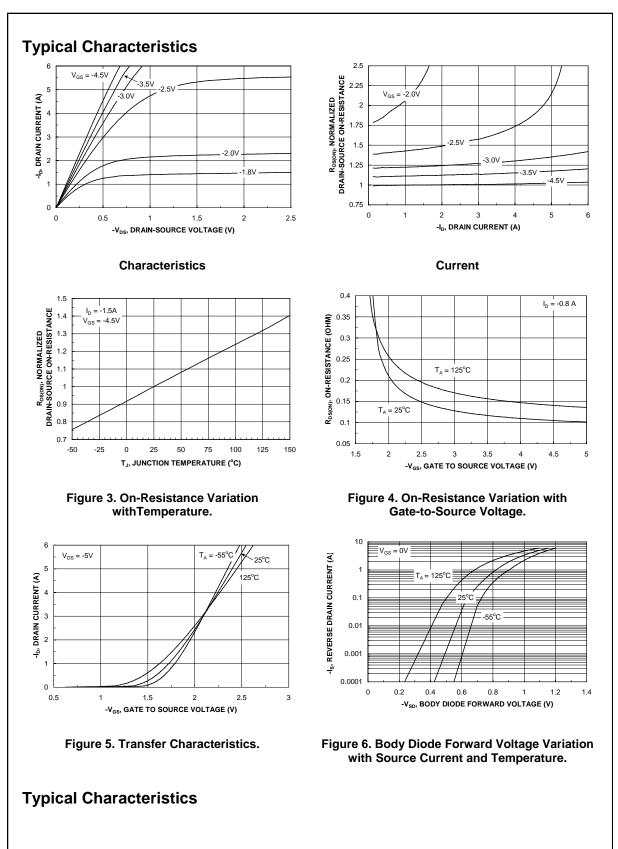
 R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

a.) 170°/W when mounted on a 1 in² pad of 2 oz. copper.

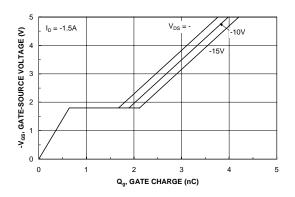
b.) 260°/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

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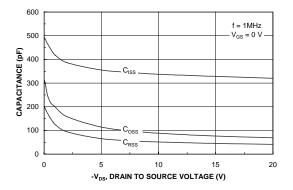


Figure 8. Capacitance Characteristics.

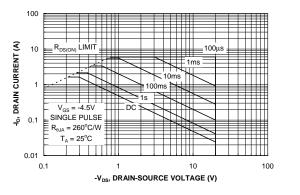


Figure 9. Maximum Safe Operating Area.

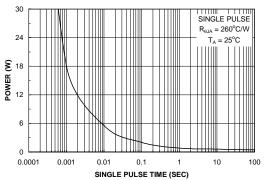


Figure 10. Single Pulse Maximum Power Dissipation.

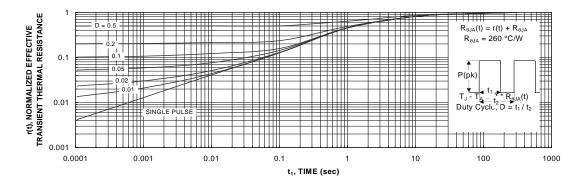


Figure 11. Transient Thermal Response Curve. Thermal characterization performed using the conditions described in Note 1c. Transient themal response will change depending on the circuit board design.

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